# Characterization of ELMs and their Effects on NSTX using Multi-color Ultrasoft X-ray Imaging

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#### Abstract

A variety of ELM phenomena is observed in NSTX, ranging from large "Type I" to less perturbative "Type III" and the recently identified "Type V". The effects these ELMs have on the plasma temperature and density profiles are assessed using multiple ultrasoft X-ray (USXR) arrays operated in a 'multi-color' (multienergy) configuration. 1-D flux surface inversion is used to obtain the local emissivity, which is then modeled using perturbed  $T_e$ , and density profiles. Fitting the 'multi-color' USXR data enables separately constraining the  $T_e$  and  $n_e$  $x n_Z$  perturbation and for instance 'propagating' the equilibrium Thompson temperature and density profiles over an ELM event. Additionally, 2-D tomographic inversion is used to assess poloidal asymmetries in the perturbations. Large Type I ELMs typically result in a crash in the SXR emission throughout the bulk plasma on a few ms timescale, which contrasts with the faster, edge-localized nature of the Type V perturbation.

\* Work supported by US DOE grant No. DE-FG02-99ER54523 at JHU and US DOE contract DE-AC02-76CH03073 at PPPL







- USXR system upgrades and setup
- Identification of distinct ELM regimes in NSTX
- Characterization and imaging of small 'Type V' ELMs
- Characterization and imaging of 'Type II/III' ELMs
- Characterization of 'Type I' ELM perturbation
- Tomographic reconstruction of Type I ELM event evolution
- Two-color USXR modeling of T<sub>e</sub> perturbation
- Summary





# Upgraded Bay G USXR System Provides Improved Spatial Coverage



- Imaging and tomographic reconstruction used to analyze plasma activity
  - Oscillatory events (MHD modes, islands)
  - Intermittent events (sawteeth, ELMs, reconnections)
    - Slow phenomena (rotating/locked modes, RWMs)

- Arrays utilize variable filter settings to change plasma region focus
  - 0.3µm Ti filter views primarily edge C emission
  - 5µm Be filter passes X-rays from bulk plasma
  - 100µm Be filter focuses on core plasma emission





Various Filters Isolate X-ray Contribution from Different Regions of Plasma







# Addition of High-speed Reentrant Array Improves Imaging Capabilities



- Reentrant diode array uses AXUV-16 from IRD
  - Fast, low-noise amplifiers have ~300kHz bandwidth
  - High speed PCI digitizer board samples at 600kHz
  - Necessary to resolve outboard plasma edge







# Spline-based Tomography Algorithm Adapted to Reconstruct SXR Emission

- Algorithm modified from R., Granetz code (MIT)
  - Ling Wang; Granetz, R.S., Rev. Sci. Instrum., 62, 1115 (1991)
- Spline basis functions allow for mode localization
  - Number/position of detector sightlines determines number of radial knots (l)
    and poloidal harmonics (m)
- Flux-surface based coefficient response matrix speeds computation







Many Different ELM Types Observed in NSTX







# Imaging of Type V ELMs show Poloidal Propagation



- ELM characterized by small edge perturbation
  - ELMs originate typically in lower plasma region
    - Propagate counter-clockwise poloidally
  - Have negligible effect on bulk plasma (T<sub>e</sub>, W, ...)
  - Regime often contains intermittent Type I events





Pedestal  $v_*^e \sim 1$  Divides Type V and Mixed ELM Regimes







# Type II/III ELM Correlates with Edge n<sub>e</sub>/Impurity Crash







# Characteristics of Type II/III ELMs



- Little impact per ELM on W<sub>MHD</sub>
- $D_{\alpha}$  spike correlates with USXR ELM events
- USXR drop shows power outflow from plasma pedestal
- Edge USXR shows power influx to SOL/separatrix
- Existence of low-frequency precursor before ELM
- High frequency MHD activity occurs at beginning of ELM







# 'Type I' ELMs Often Observed in High Performance NSTX Discharges







# Type I ELM often Accompanied by Global T<sub>e</sub> Perturbation

- Thompson measures drop in  $T_e(r)$  on the order of 10-20% ( $\Delta T_{core} \sim \Delta T_{edge}$ )
  - n<sub>e</sub> measured before, during, and after ELM shows little change (slight peaking?) pure conductive ELM? (i.e. n⊽T change only)
  - Neutron response lags  $T_e$  profile (decline by ~1ms, minimum by ~5ms)
  - Not all  $T_e$  perturbations reach core (e.g. shot 113665 @ 0.377s, 112581 @ 0.537s)







### USXR Indicates Redistribution of Emission Prior to Main ELM Event



- Redistribution of SXR emission occurs ~few 100ms before ELM crash
  - Core emission shows modest decline
  - Edge SXR emission increases, peaks shortly after ELM crash
  - $D_{\alpha}$  burst corresponds to ELM crash NOT increase in SXR edge emission
- Outflow of power into SOL occurs at ELM crash

shot# 112503

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#### USXR Arrays Allow Tomographic Reconstruction of Type I ELM Perturbation





#### ELM erodes "bump" at inboard of plasma

- Perturbation reaches  $\psi_N \sim 0.25 (0.7 \text{m})$ inboard, 1.27m outboard)
- Radial propagation ~few 100µs

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Preliminary hints that ELM size/ propagation boundary related to I<sub>p</sub>



R(m)



0.6

0.8

1.0

R (m)

1.2

1.4

0.4

Relative midplane intensity change







# Larger ELM Events Indicate Penetration of Perturbation to Core

- Core emission crashes ~1ms after edge
  - Larger decrease in neutron rate compared to 0.537 event (~20% vs ~3%)
  - Consistent with multi-color T<sub>e</sub> modeling
- Radial propagation of perturbation appears to slow in plasma core



Tomographic reconstruction of shot 112581 @ .656s, Be 100 $\mu$ m filters

Relative midplane intensity change









- Pre-ELM MPTS profiles used to fix n<sub>e</sub>, n<sub>z</sub> in USXR model
  - USXR profiles modeled using C, O and B coronal equilibrium radiative coefficients and magnetic surface mapping
- Ratio of Be 100 $\mu$ m/5 $\mu$ m filters sensitive function of T<sub>e</sub>
  - 2-color modeling provides  $T_e(R,t)$  with good temporal resolution
  - $T_e \text{ crash in pedestal ~40-80\%, core ~10-20\%} \left(\frac{\Delta T}{T_{core}} \neq \frac{\Delta T}{T_{edge}}\right)$
  - Core perturbation consistent with ~20% reduction in neutron flux
  - Propagated  $T_e(R)$  matches well with subsequent MPTS profile
  - Limitations of technique
    - Crossed arrays allow only 1-D modeling
    - Assumption of no asymmetric density shifts or plasma movement
    - Set of multi-color arrays would alleviate these limitations









# Planned Experiment: Characterization and Scaling of Type I ELMs on NSTX

# • Motivation

- ELM phenomena on NSTX appears different from conventional tokamaks (e.g. size scaling, perturbative penetration)
- On conventional tokamak, ELM is mixture of  $n_e$ ,  $T_e$  perturbation and relative proportion scales with collisionality
- Effects of conductive ELMs more damaging to power handling structures

#### Goals

- Understand the scaling of conductive/convective ELM proportionality on NSTX
- Investigate the dependence of the propagation and penetration of the Type I ELM perturbation





- Upgraded USXR set provies good plasma coverage
  - High-speed reentrant array boosts fast imaging capabilities
  - Some portions of plasma volume still under-sampled
- Various ELM phenomena have been imaged using the USXR arrays
  - Imaging of Type V ELMs show poloidal propagation
  - Type III ELMs correlate with edge n<sub>e</sub> perturbation and subsequent localized USXR emission bloom
  - Type I ELMs often accompanied by a global T<sub>e</sub> perturbation
- Multi-color USXR modeling is a powerful tool for fast T<sub>e</sub> profile analysis
- Planned experiment will investigate scaling and characterization of Type I ELM perturbation